# **PZT2907A**

# PNP Silicon Epitaxial Transistor

This PNP Silicon Epitaxial transistor is designed for use in linear and switching applications. The device is housed in the SOT-223 package which is designed for medium power surface mount applications.

#### **Features**

- NPN Complement is PZT2222AT1
- The SOT-223 Package can be Soldered Using Wave or Reflow
- SOT-223 Package Ensures Level Mounting, Resulting in Improved Thermal Conduction, and Allows Visual Inspection of Soldered Joints. The Formed Leads Absorb Thermal Stress during Soldering Eliminating the Possibility of Damage to the Die
- S Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant\*

## **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Collector - Emitter Voltage	$V_{CEO}$	-60	Vdc
Collector - Base Voltage	V <sub>CBO</sub>	-60	Vdc
Emitter – Base Voltage	V <sub>EBO</sub>	-5.0	Vdc
Collector Current – Continuous	I <sub>C</sub>	-600	mAdc

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

## THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation (Note 1) $T_A = 25^{\circ}C$	P <sub>D</sub>	1.5 12	W mW/°C
Thermal Resistance Junction-to-Ambient (Note 1)	$R_{\theta JA}$	83.3	°C/W
Lead Temperature for Soldering, 0.0625" from case Time in Solder Bath	TL	260 10	°C Sec
Operating and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-65 to +150	°C

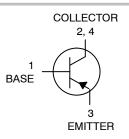
<sup>1.</sup> FR-4 with 1 oz and 713 mm<sup>2</sup> of copper area.



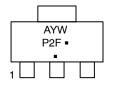
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#### MARKING DIAGRAM



P2F = Specific Device Code A = Assembly Location

Y = Year W = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

## **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
PZT2907AT1G	SOT-223 (Pb-Free)	1,000 / Tape & Reel
SPZT2907AT1G	SOT-223 (Pb-Free)	1,000 / Tape & Reel
PZT2907AT3G	SOT-223 (Pb-Free)	4,000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# **PZT2907A**

# **ELECTRICAL CHARACTERISTICS** ( $T_A = 25^{\circ}C$ unless otherwise noted)

Cha	Symbol	Min	Тур	Max	Unit	
OFF CHARACTERISTICS						
Collector-Base Breakdown Volta (I <sub>C</sub> = -10 μAdc, I <sub>E</sub> = 0)	V <sub>(BR)CBO</sub>	-60	-	_	Vdc	
Collector-Emitter Breakdown Vol (I <sub>C</sub> = 10 mAdc, I <sub>B</sub> = 0)	tage	V <sub>(BR)CEO</sub>	-60	-	_	Vdc
Emitter-Base Breakdown Voltage $(I_E = -10 \mu Adc, I_C = 0)$	9	V <sub>(BR)EBO</sub>	-5.0	-	-	Vdc
Collector–Base Cutoff Current $(V_{CB} = -50 \text{ Vdc}, I_E = 0)$		I <sub>CBO</sub>	-	-	-10	nAdc
Collector-Emitter Cutoff Current (V <sub>CE</sub> = -30 Vdc, V <sub>BE</sub> = 0.5 Vdc	c)	I <sub>CEX</sub>	-	-	-50	nAdc
Base-Emitter Cutoff Current (V <sub>CE</sub> = -30 Vdc, V <sub>BE</sub> = -0.5 Vdc)	dc)	I <sub>BEX</sub>	-	-	-50	nAdc
ON CHARACTERISTICS (No	te 2)			l		
$\begin{array}{c} \text{DC Current Gain} \\ \text{($I_{C} = -0.1$ mAdc, $V_{CE} = -10$ Vol. $(I_{C} = -1.0$ mAdc, $V_{CE} = -10$ Vol. $(I_{C} = -10$ mAdc, $V_{CE} = -10$ Vol. $(I_{C} = -150$ mAdc, $V_{CE} = -10$ Vol. $(I_{C} = -500$ mAdc, $V_{CE} = -10$ Vol. $$	dc) c) dc)	h <sub>FE</sub>	75 100 100 100 50	- - - -	- - 300	-
Collector-Emitter Saturation Voltages ( $I_C = -150 \text{ mAdc}$ , $I_B = -15 \text{ mAdc}$ ) ( $I_C = -500 \text{ mAdc}$ , $I_B = -50 \text{ mAdc}$ )		V <sub>CE(sat)</sub>	- -	- -	-0.4 -1.6	Vdc
Base-Emitter Saturation Voltages $(I_C = -150 \text{ mAdc}, I_B = -15 \text{ mAdc})$ $(I_C = -500 \text{ mAdc}, I_B = -50 \text{ mAdc})$		V <sub>BE(sat)</sub>	- -	- -	-1.3 -2.6	Vdc
DYNAMIC CHARACTERISTI	cs			l		
Current-Gain – Bandwidth Product (I <sub>C</sub> = -50 mAdc, V <sub>CE</sub> = -20 Vdc, f = 100 MHz)		f <sub>T</sub>	200	-	_	MHz
Output Capacitance (V <sub>CB</sub> = -10 Vdc, I <sub>E</sub> = 0, f = 1.0 MHz)		C <sub>c</sub>	-	-	8.0	pF
Input Capacitance $(V_{EB} = -2.0 \text{ Vdc}, I_C = 0, f = 1.0 \text{ MHz})$		C <sub>e</sub>	-	-	30	pF
SWITCHING TIMES						
Turn-On Time		t <sub>on</sub>	-	-	45	ns
Delay Time	$(V_{CC} = -30 \text{ Vdc}, I_{C} = -150 \text{ mAdc}, I_{B1} = -15 \text{ mAdc})$	t <sub>d</sub>	_	-	10	
Rise Time		t <sub>r</sub>	_	-	40	
Turn-Off Time		t <sub>off</sub>	ı	_	100	ns
Storage Time	$(V_{CC} = -6.0 \text{ Vdc}, I_{C} = -150 \text{ mAdc}, I_{B1} = I_{B2} = -15 \text{ mAdc})$	t <sub>s</sub>	-	_	80	
Fall Time		t <sub>f</sub>	-	-	30	

<sup>2.</sup> Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2.0%.

### **PZT2907A**

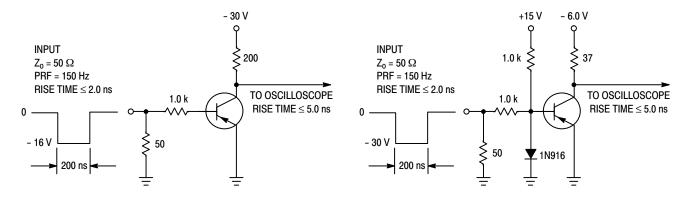


Figure 1. Delay and Rise **Time Test Circuit** 

Figure 2. Storage and Fall **Time Test Circuit** 

## TYPICAL ELECTRICAL CHARACTERISTICS

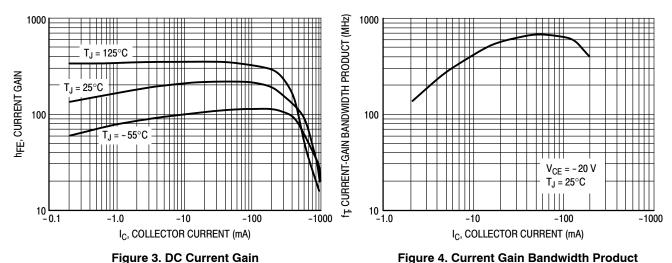


Figure 3. DC Current Gain

 $V_{BE(sat)} @ I_C/I_B = 10$ 

V<sub>BE(on)</sub> @ V<sub>CE</sub> = -10 V

 $V_{CE(sat)} @ I_C/I_B = 10$ 

-1.0

- 0.8

- 0.2

VOLTAGE (VOLTS)

 $T_J = 25^{\circ}C$ 

30 20 10 7.0 Ccb 5.0 3.0 2.0 REVERSE VOLTAGE (VOLTS)

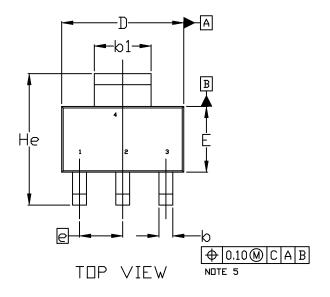
Figure 5. "ON" Voltage

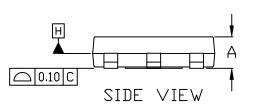
Figure 6. Capacitances

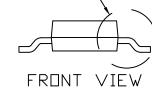


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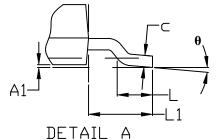
**DATE 02 OCT 2018** 







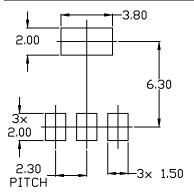
SEE DETAIL A



#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. DIMENSIONS D & E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
  MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.200MM PER SIDE.
- 4. DATUMS A AND B ARE DETERMINED AT DATUM H.
- 5. ALLIS DEFINED AS THE VERTICAL DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT OF THE PACKAGE BODY.
- 6. POSITIONAL TOLERANCE APPLIES TO DIMENSIONS 6 AND 61.

	MILLIMETERS			
DIM	MIN.	N□M.	MAX.	
Α	1.50	1.63	1.75	
A1	0.02	0.06	0.10	
Ø	0.60	0.75	0.89	
b1	2.90	3.06	3.20	
U	0.24	0.29	0.35	
D	6.30	6.50	6.70	
E	3.30	3.50	3.70	
е	2.30 BSC			
L	0.20			
L1	1.50	1.75	2.00	
He	6.70	7.00	7.30	
θ	0°		10°	



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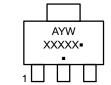
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**DATE 02 OCT 2018** 

STYLE 1: PIN 1. BASE 2. COLLECTOR 3. EMITTER 4. COLLECTOR	STYLE 2: PIN 1. ANODE 2. CATHODE 3. NC 4. CATHODE	STYLE 3: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN	STYLE 4: PIN 1. SOURCE 2. DRAIN 3. GATE 4. DRAIN	STYLE 5: PIN 1. DRAIN 2. GATE 3. SOURCE 4. GATE
STYLE 6: PIN 1. RETURN 2. INPUT 3. OUTPUT 4. INPUT	STYLE 7: PIN 1. ANODE 1 2. CATHODE 3. ANODE 2 4. CATHODE	STYLE 8: CANCELLED	STYLE 9: PIN 1. INPUT 2. GROUND 3. LOGIC 4. GROUND	STYLE 10: PIN 1. CATHODE 2. ANODE 3. GATE 4. ANODE
STYLE 11: PIN 1. MT 1 2. MT 2 3. GATE 4. MT 2	STYLE 12: PIN 1. INPUT 2. OUTPUT 3. NC 4. OUTPUT	STYLE 13: PIN 1. GATE 2. COLLECTOR 3. EMITTER 4. COLLECTOR		

# GENERIC MARKING DIAGRAM\*



A = Assembly Location

Y = Year W = Work Week

 $XXXXX \ = Specific \ Device \ Code$ 

= Pb-Free Package

(Note: Microdot may be in either location)
\*This information is generic. Please refer to
device data sheet for actual part marking.
Pb-Free indicator, "G" or microdot "•", may
or may not be present. Some products may
not follow the Generic Marking.

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